

Support Information

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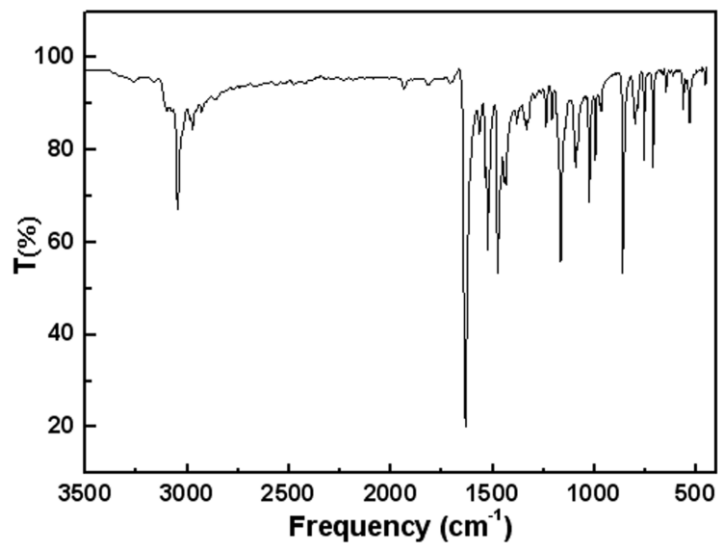


Figure S1. FT-IR spectroscopic characterization for complex 1.

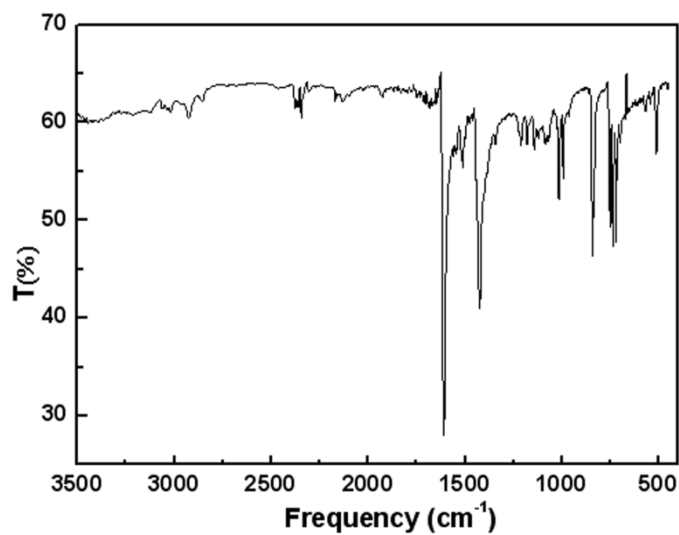


Figure S2. FT-IR spectroscopic characterization for complex 2.

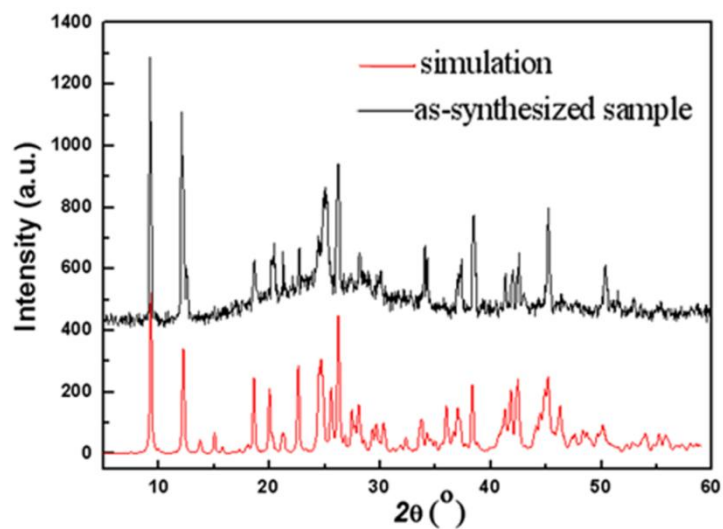


Figure S3. XRPD patterns of simulated from a single crystal of complex **1** (red), and as-synthesized sample of complex **1** (dark).

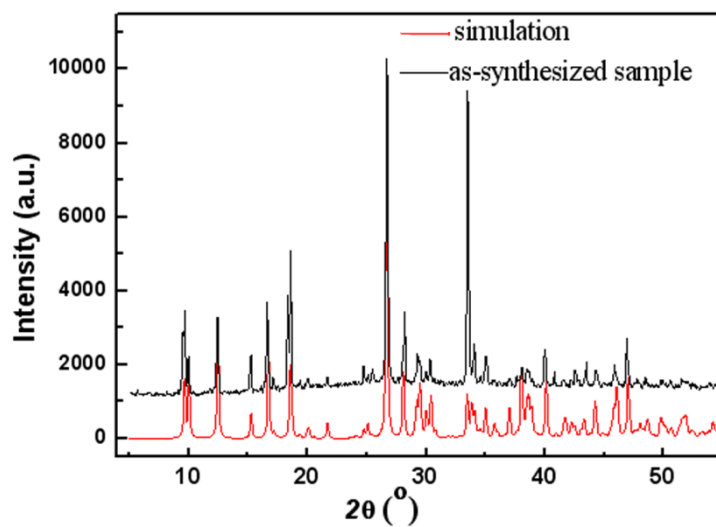


Figure S4. XRPD patterns of simulated from a single crystal of complex **2** (red), and as-synthesized sample of complex **2** (dark).

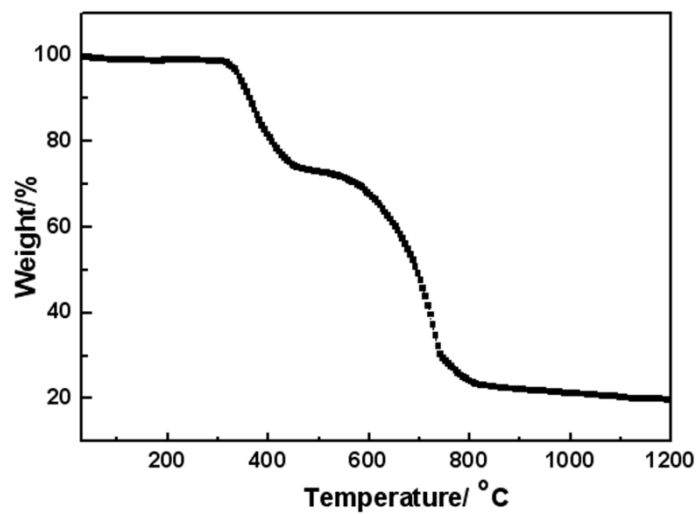


Figure S5. TGA profile for complex 1.

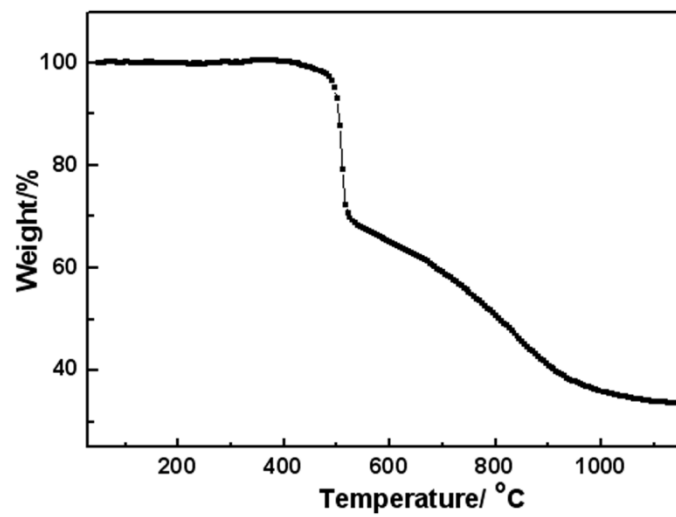


Figure S6. TGA profile for complex 2.